'INFORMATION CITED BY APPLICANT THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicant:

S.J. Crampton

Attorney Docket No. BRSF119831

Title:

SCANNING APPARATUS AND METHOD

U.S. PATENT DOCUMENTS

*Examiner Initials	Cite No.	Document No.	Kind Code	Date (mm/dd/yyyy)	Name
	U1	4,649,504		03/10/1987	Krouglicof et al.
	U2	4,825,391		04/05/1989	Merz
	U3	4,982,102		01/01/1991	Inoue et al.
	U4	4,993,835		02/19/1991	Inoue et al.
	U5	5,090,811		02/25/1992	Donaldson
	U6	5,168,528		12/01/1992	Field, Jr.
	U 7	5,191,642		03/02/1993	Quick et al.
	U8	5,198,877		03/30/1993	Schulz
	U9	5,251,296		10/05/1993	Rhoden et al.
	U10	5,255,096		10/19/1993	Boyle
	U11	5,264,678		11/23/1993	Powell et al.
	U12	5,268,996		12/07/1993	Steiner et al.
	U13	5,357,599		10/18/1994	Luken
	U14	5,886,703		03/23/1999	Mauldin

FOREIGN PATENT DOCUMENTS

*E	Examiner Initial	Cite No.	Document No.	Kind Code	Publication Date (mm/dd/yyyy)	Country	English Abstract Provided	Translation Provided
		F1	DE 3 938 714	A 1	05/29/1991	DE		
		F2	PCT/AT91/00115		05/14/1992	DE		X
_		F3	EP 0 159 187	A 1	10/23/1985	EP		
		F4	PCT/FR90/00090		08/09/1990	FR		
_		F5	GB 2 264 601	Α	09/01/1993	GB		
		F6	GB 2 264 602	Α	09/01/1993	GB		
		F7	PCT/GB95/01994		02/29/1996	GB		

LAW OFFICES OF CHRISTENSEN O'CONNOR JOHNSON KINDNESS**LC 1420 Fifth Avenue Suite 2800 Seattle, Washington 98101 206.682.8100

*Examiner	Cite		Kind	Publication Date		Abstract	Translation
Initial	No.	Document No.	Code	(mm/dd/yyyy)	Country	Provided	Provided
	F8	PCT/US91/07511		04/30/1992	US		
	F9	WO 96/10205		04/04/1996	WIPO		
				INFORMATION tle, Date, Pertinent I	Pages, Etc.)		
*Examiner							
<u>Initial</u>	No	•					
	O1			cKay, "A Method for crn Analysis and Mac	_	-	
	O2	Fisher, R.B., et al., "A Hand-Held Optical Surface Scanner for Environmental Modeling and Virtual Reality," <i>Proceedings of Virtual Reality World</i> , Stuttgar Germany, February 1996.					
O3 Sakaguchi, Y., et al., "Acquisition of Entire Surface Data Based Range Data," <i>IEICE Transactions E74</i> (10):3417-3421, October							on of
Examiner		•		Date Considered			

*Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

SYS:mgp

English